2023년 2월 13일(월)~ 15일(수) | 강원도 하이원리조트(그랜드호텔 컨벤션타워)

2023년 2월 15일(수), 09:00-10:15 Room L (다이아몬드 II, 6층)

G. Device & Process Modeling, Simulation and Reliability 분과 [WL1-G] Phase-Field, Molecular Dyamics Simulation and Carrier Transport

좌장: 장지원 교수(연세대학교), 홍성민 교수(GIST)

WL1-G-1 09:00-09:30 [초청]	Phase-field Method and Its Application to Semiconductor Device and Process Simulation Yongwoo Kwon Hongik University
WL1-G-2 09:30-09:45	Multi-Level Storage in Cleaved-Gate Ferroelectric FETs Investigated by 3D Phase-Field Based Quantum Transport Simulation Jeonghwan Jang, Hyeongu Lee, and Mincheol Shin School of Electrical Engineering, KAIST
WL1-G-3 09:45-10:00	Investigation of Thermal Stress Effects and Delamination during Annealing of HfO ₂ Thin Film Using Molecular Dynamics Simulations Kiran Raj and Yongwoo Kwon Department of Materials Science and Engineering, Hongik University
WL1-G-4 10:00-10:15	Multi-physics Boltzmann Transport Simulation in Nanowire by Coupling Multiple Physics-informed Deep Operator Networks Bokyeom Kim and Mincheol Shin School of Electrical Engineering, KAIST